

Cascadable Silicon Bipolar MMIC Amplifiers

Technical Data

MSA-0635, -0636

Features

- **Cascadable 50 Ω Gain Block**
- **Low Operating Voltage:**
3.5 V Typical V_d
- **3 dB Bandwidth:**
DC to 0.9 GHz
- **High Gain:**
19.0 dB Typical at 0.5 GHz
- **Low Noise Figure:**
2.8 dB Typical at 0.5 GHz
- **Cost Effective Ceramic Microstrip Package**

Description

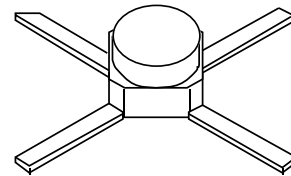
The MSA-0635 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) housed in a cost effective, microstrip package. This MMIC is

designed for use as a general purpose 50 Ω gain block. Typical applications include narrow and broad band IF and RF amplifiers in commercial and industrial applications.

The MSA-series is fabricated using HP's 10 GHz f_T , 25 GHz f_{MAX} , silicon bipolar MMIC process which uses nitride self-alignment, ion implantation, and gold metallization to achieve excellent performance, uniformity and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

Available in cut lead version (package 36) as MSA-0636.

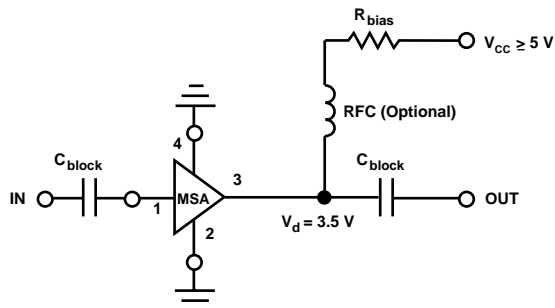
35 micro-X Package^[1]



Note:

1. Short leaded 36 package available upon request.

Typical Biasing Configuration



MSA-0635, -0636 Absolute Maximum Ratings

| Parameter | Absolute Maximum ^[1] |
|------------------------------------|---------------------------------|
| Device Current | 50 mA |
| Power Dissipation ^[2,3] | 200 mW |
| RF Input Power | +13 dBm |
| Junction Temperature | 200°C |
| Storage Temperature ^[4] | -65 to 200°C |

Thermal Resistance^[2,5]:

$$\theta_{jc} = 155^{\circ}\text{C/W}$$

Notes:

1. Permanent damage may occur if any of these limits are exceeded.
2. $T_{\text{CASE}} = 25^{\circ}\text{C}$.
3. Derate at $6.5 \text{ mW}/^{\circ}\text{C}$ for $T_{\text{C}} > 169^{\circ}\text{C}$.
4. Storage above $+150^{\circ}\text{C}$ may tarnish the leads of this package making it difficult to solder into a circuit.
5. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications^[1], $T_{\text{A}} = 25^{\circ}\text{C}$

| Symbol | Parameters and Test Conditions: $I_{\text{d}} = 16 \text{ mA}$, $Z_{\text{o}} = 50 \Omega$ | Units | Min. | Typ. | Max. |
|-----------------------|---|------------------------|------|-----------|-----------|
| G_{P} | Power Gain ($ S_{21} ^2$) $f = 0.1 \text{ GHz}$ | dB | 19.0 | 20.5 | 22.0 |
| ΔG_{P} | Gain Flatness $f = 0.1 \text{ to } 2.5 \text{ GHz}$ | dB | | ± 0.7 | ± 1.0 |
| $f_{3 \text{ dB}}$ | 3 dB Bandwidth | GHz | | 0.9 | |
| VSWR | Input VSWR $f = 0.1 \text{ to } 1.5 \text{ GHz}$ | | | 1.4:1 | |
| | Output VSWR $f = 0.1 \text{ to } 1.5 \text{ GHz}$ | | | 1.3:1 | |
| NF | 50 Ω Noise Figure $f = 0.5 \text{ GHz}$ | dB | | 2.8 | 4.0 |
| $P_{1 \text{ dB}}$ | Output Power at 1 dB Gain Compression $f = 0.5 \text{ GHz}$ | dBm | | 2.0 | |
| IP_3 | Third Order Intercept Point $f = 0.5 \text{ GHz}$ | dBm | | 14.5 | |
| t_{D} | Group Delay $f = 0.5 \text{ GHz}$ | psec | | 200 | |
| V_{d} | Device Voltage | V | 3.1 | 3.5 | 3.9 |
| dV/dT | Device Voltage Temperature Coefficient | mV/ $^{\circ}\text{C}$ | | -8.0 | |

Note:

1. The recommended operating current range for this device is 12 to 30 mA. Typical performance as a function of current is on the following page.

MSA-0635, -0636 Typical Scattering Parameters ($Z_0 = 50 \Omega$, $T_A = 25^\circ\text{C}$, $I_d = 16 \text{ mA}$)

| Freq. GHz | S ₁₁ | | S ₂₁ | | | S ₁₂ | | | S ₂₂ | | k |
|-----------|-----------------|------|-----------------|-------|-----|-----------------|------|-----|-----------------|------|------|
| | Mag | Ang | dB | Mag | Ang | dB | Mag | Ang | Mag | Ang | |
| 0.1 | .03 | -178 | 20.5 | 10.59 | 171 | -23.4 | .068 | 5 | .04 | -44 | 1.05 |
| 0.2 | .02 | -177 | 20.3 | 10.31 | 161 | -22.9 | .071 | 8 | .05 | -68 | 1.04 |
| 0.3 | .02 | -164 | 20.0 | 9.96 | 152 | -22.4 | .076 | 14 | .06 | -87 | 1.04 |
| 0.4 | .02 | -116 | 19.6 | 9.55 | 144 | -22.0 | .079 | 19 | .07 | -104 | 1.03 |
| 0.5 | .02 | -100 | 19.2 | 9.08 | 136 | -21.8 | .081 | 21 | .09 | -114 | 1.04 |
| 0.6 | .04 | -89 | 18.7 | 8.59 | 128 | -21.3 | .086 | 24 | .09 | -123 | 1.04 |
| 0.8 | .07 | -96 | 17.7 | 7.66 | 115 | -20.2 | .098 | 29 | .10 | -140 | 1.03 |
| 1.0 | .10 | -108 | 16.6 | 6.79 | 103 | -19.4 | .107 | 31 | .11 | -156 | 1.02 |
| 1.5 | .17 | -134 | 14.2 | 5.13 | 79 | -17.2 | .138 | 30 | .12 | 172 | 1.03 |
| 2.0 | .24 | -160 | 12.1 | 4.01 | 60 | -15.8 | .163 | 26 | .12 | 148 | 1.04 |
| 2.5 | .31 | -178 | 10.3 | 3.26 | 48 | -15.1 | .175 | 27 | .12 | 140 | 1.08 |
| 3.0 | .37 | 166 | 8.7 | 2.72 | 34 | -14.4 | .190 | 24 | .11 | 135 | 1.10 |
| 3.5 | .42 | 151 | 7.4 | 2.33 | 21 | -13.9 | .203 | 19 | .10 | 144 | 1.11 |
| 4.0 | .46 | 139 | 6.2 | 2.04 | 9 | -13.3 | .216 | 16 | .08 | 167 | 1.11 |
| 4.5 | .48 | 126 | 5.1 | 1.81 | -3 | -12.8 | .229 | 12 | .08 | -173 | 1.11 |
| 5.0 | .52 | 110 | 4.2 | 1.62 | -15 | -12.2 | .245 | 8 | .09 | -173 | 1.09 |

Note:

1. A model for this device is available in the DEVICE MODELS section.

Typical Performance, $T_A = 25^\circ\text{C}$

(unless otherwise noted)

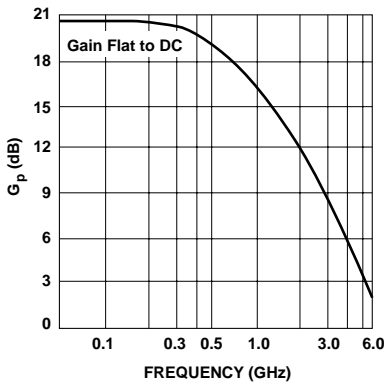


Figure 1. Typical Power Gain vs. Frequency, $I_d = 16 \text{ mA}$.

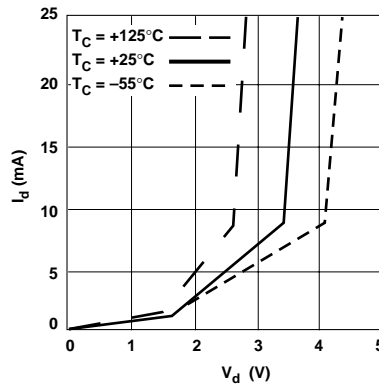


Figure 2. Device Current vs. Voltage.

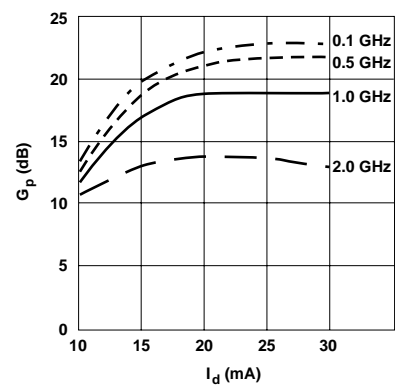


Figure 3. Power Gain vs. Current.

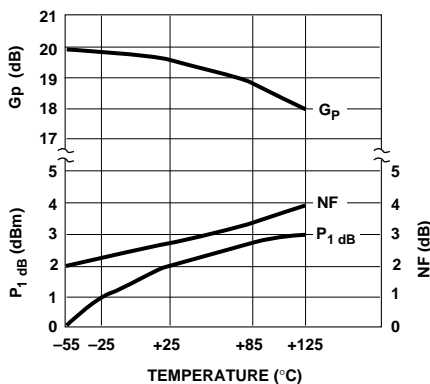


Figure 4. Output Power at 1 dB Gain Compression, NF and Power Gain vs. Case Temperature, $f = 0.5 \text{ GHz}$, $I_d = 16 \text{ mA}$.

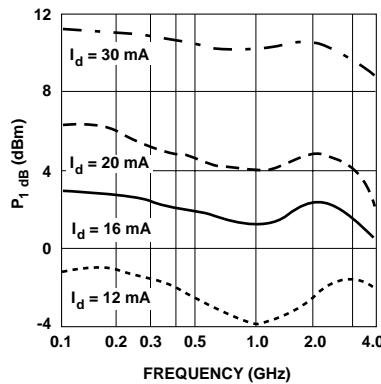


Figure 5. Output Power at 1 dB Gain Compression vs. Frequency.

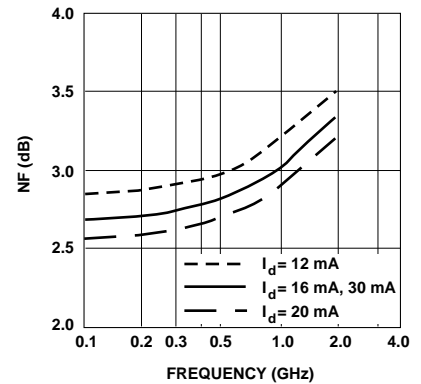


Figure 6. Noise Figure vs. Frequency.

35 micro-X Package Dimensions

